

**FAIRCHILD**

A Schlumberger Company

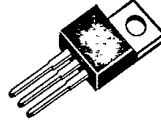
**FMP20N05/FMP18N05** T-39-11  
**N-Channel Power MOSFETs,  
18-20 A, 50 V**

Power And Discrete Division

**Description**

These devices are very low  $R_{DS(on)}$ , 50 V, n-channel, enhancement mode, power MOSFETs especially designed to serve the low voltage, high speed, switching markets. Typical applications are SMPS for telecommunication and instrumentation, DC motor controls, emitter switching, synchronous rectification, and systems that are operated from low voltage batteries, such as automotive and portable equipment, etc.

TO-220AB



IS00000F

FMP18N05  
FMP20N05

- Extremely low  $R_{DS(on)}$
- $V_{GS}$  Rated at  $\pm 30$  V
- Silicon Gate for Fast Switching Speeds
- Rugged
- Low Drive Requirements
- Ease of Paralleling

**Maximum Ratings**

Symbol	Characteristic	Rating FMP20N05	Rating FMP18N05	Unit
$V_{DSS}$	Drain to Source Voltage <sup>1</sup>	50	50	V
$V_{DGR}$	Drain to Gate Voltage <sup>1</sup> $R_{GS} = 20 \text{ k}\Omega$	50	50	V
$V_{GS}$	Gate to Source Voltage	$\pm 30$	$\pm 30$	V
$T_J, T_{stg}$	Operating Junction and Storage Temperatures	-55 to +150	-55 to +150	$^{\circ}\text{C}$
$T_L$	Maximum Lead Temperature for Soldering Purposes, 1/8" From Case for 5 s	300	300	$^{\circ}\text{C}$

**Maximum On-State Characteristics**

		FMP20N05	FMP18N05	
$R_{DS(on)}$	Static Drain-to-Source On Resistance	0.085	0.10	$\Omega$
$I_D$	Drain Current			A
	Continuous at $T_C = 25^{\circ}\text{C}$	20	18	
	Continuous at $T_C = 100^{\circ}\text{C}$	14	13	
	Pulsed	60	50	

**Maximum Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.67	1.67	$^{\circ}\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	80	80	$^{\circ}\text{C}/\text{W}$
$P_D$	Total Power Dissipation at $T_C = 25^{\circ}\text{C}$	75	75	W

**Notes**

For information concerning connection diagram and package outline, refer to Section 7.

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**FMP18N05**

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**Electrical Characteristics** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

Symbol	Characteristic	Min	Max	Unit	Test Conditions
<b>Off Characteristics</b>					
$V_{(BR)DSS}$	Drain Source Breakdown Voltage <sup>1</sup>	50		V	$V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$
$I_{DSS}$	Zero Gate Voltage Drain Current		250	$\mu\text{A}$	$V_{DS} = \text{Rated } V_{DSS}, V_{GS} = 0\text{ V}$
			1000	$\mu\text{A}$	$V_{DS} = 0.8 \times \text{Rated } V_{DSS}, V_{GS} = 0\text{ V}, T_C = 125^\circ\text{C}$
$I_{GSS}$	Gate-Body Leakage Current		$\pm 500$	nA	$V_{GS} = \pm 20\text{ V}, V_{DS} = 0\text{ V}$
<b>On Characteristics</b>					
$V_{GS(th)}$	Gate Threshold Voltage	2.0	4.0	V	$I_D = 250\ \mu\text{A}, V_{DS} = V_{GS}$
$R_{DS(on)}$	Static Drain-Source On-Resistance <sup>2</sup>			$\Omega$	$V_{GS} = 10\text{ V}, I_D = 10\text{ A}$
		FMP20N05	0.085		
		FMP18N05	0.10		
$V_{DS(on)}$	Drain-Source On-Voltage <sup>2</sup>		2.0	V	$V_{GS} = 10\text{ V}; I_D = 20\text{ A};$
		FMP18N05	2.25		
		FMP20N05 FMP18N05	1.40	V	$V_{GS} = 10\text{ V}; I_D = 10\text{ A};$ $T_C = 100^\circ\text{C}$
$g_{fs}$	Forward Transconductance	5		S ( $\Omega$ )	$V_{DS} = 10\text{ V}, I_D = 10\text{ A}$
<b>Dynamic Characteristics</b>					
$C_{iss}$	Input Capacitance		850	pF	$V_{DS} = 25\text{ V}, V_{GS} = 0\text{ V}$ $f = 1.0\text{ MHz}$
$C_{oss}$	Output Capacitance		400	pF	
$C_{rss}$	Reverse Transfer Capacitance		150	pF	
<b>Switching Characteristics</b> ( $T_C = 25^\circ\text{C}$ , Figures 9, 10)					
$t_{d(on)}$	Turn-On Delay Time		50	ns	$V_{DD} = 40\text{ V}, I_D = 10\text{ A}$ $V_{GS} = 10\text{ V}, R_{GEN} = 50\ \Omega$ $R_{GS} = 50\ \Omega$
$t_r$	Rise Time		90	ns	
$t_{d(off)}$	Turn-Off Delay Time		60	ns	
$t_f$	Fall Time		75	ns	
$Q_g$	Total Gate Charge		20	nC	$V_{GS} = 10\text{ V}, I_D = 25\text{ A}$ $V_{DD} = 40\text{ V}$

Symbol	Characteristic	Typ	Max	Unit	Test Conditions
<b>Source-Drain Diode Characteristics</b>					
$V_{SD}$	Diode Forward Voltage		1.5	V	$I_S = 20\text{ A}; V_{GS} = 0\text{ V}$
$t_{rr}$	Reverse Recovery Time	60		ns	$I_S = 20\text{ A}; di_S/dt = 50\text{ A}/\mu\text{S}$

**Notes**

- $T_J = +25^\circ\text{C}$  to  $+150^\circ\text{C}$
- Pulse test: Pulse width  $\leq 80\ \mu\text{s}$ , Duty cycle  $\leq 1\%$

Typical Performance Curves

Figure 1 Output Characteristics

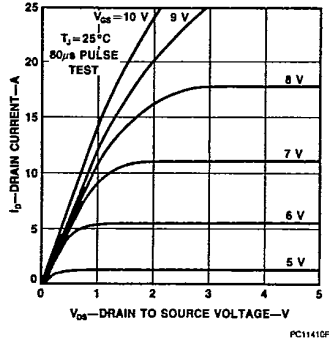


Figure 2 Static Drain to Source Resistance vs Drain Current

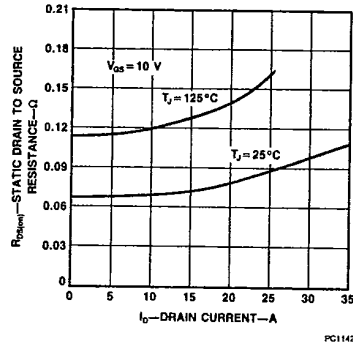


Figure 3 Transfer Characteristics

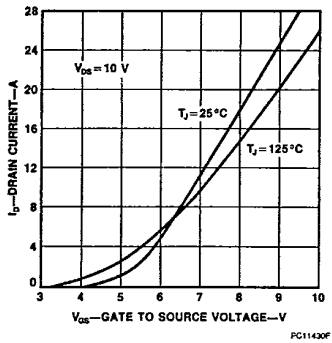


Figure 4 Temperature Variation of Gate to Source Threshold Voltage

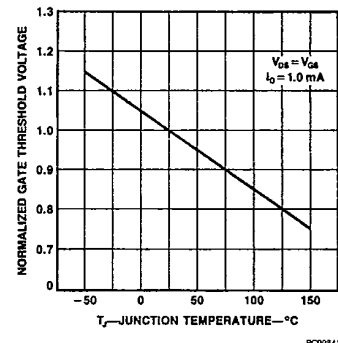


Figure 5 Capacitance vs Drain to Source Voltage

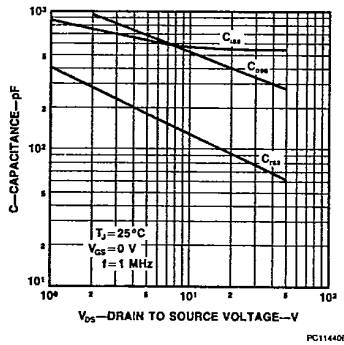
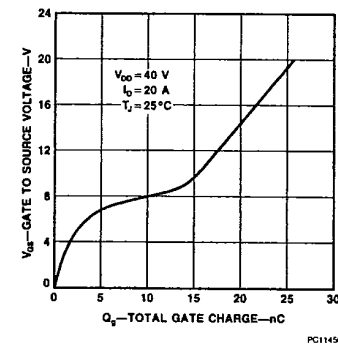


Figure 6 Gate to Source Voltage vs Total Gate Charge



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Typical Performance Curves (Cont.)

Figure 7 Forward Biased Safe Operating Area

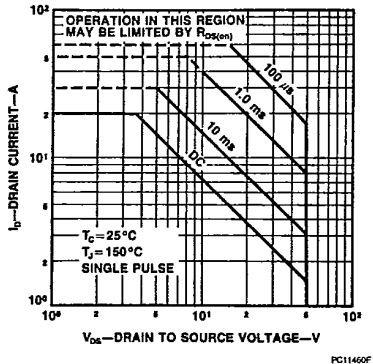
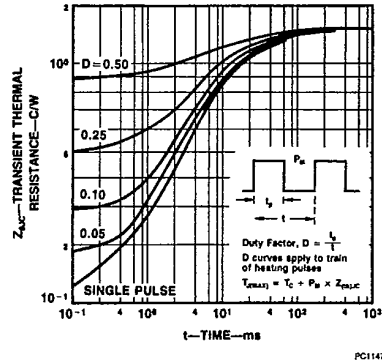


Figure 8 Transient Thermal Resistance vs Time



Typical Electrical Characteristics

Figure 9 Switching Test Circuit

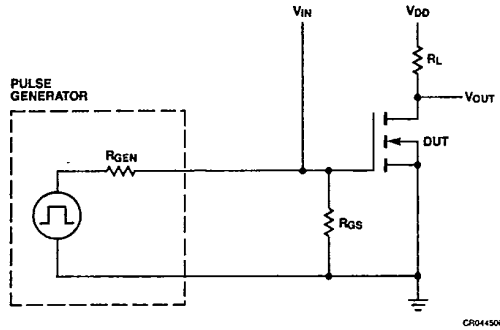


Figure 10 Switching Waveforms

